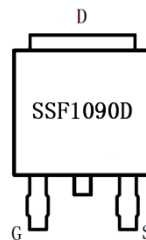
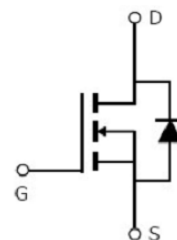


**Main Product Characteristics:**

$V_{DS}$	100V
$R_{DS(on)}$	60m $\Omega$ (typ.)
$I_D$	15A ①



TO-252 (D-PAK)


 Marking and pin  
Assignment


Schematic diagram

**Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature


**Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

**Absolute max Rating:**

Symbol	Parameter	Max.	Units
$I_D$ @ TC = 25°C	Continuous Drain Current, $V_{GS}$ @ 10V ①	15	A
$I_D$ @ TC = 100°C	Continuous Drain Current, $V_{GS}$ @ 10V ①	10	
$I_{DM}$	Pulsed Drain Current ②	60	
$P_D$ @TC = 25°C	Power Dissipation ③	39	W
	Linear Derating Factor	0.26	W/°C
$V_{DS}$	Drain-Source Voltage	100	V
$V_{GS}$	Gate-to-Source Voltage	± 20	V
$E_{AS}$	Single Pulse Avalanche Energy @ L=22mH	142	mJ
$I_{AS}$	Avalanche Current @ L=22mH	3.6	A
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	°C

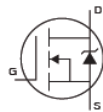
## Thermal Resistance

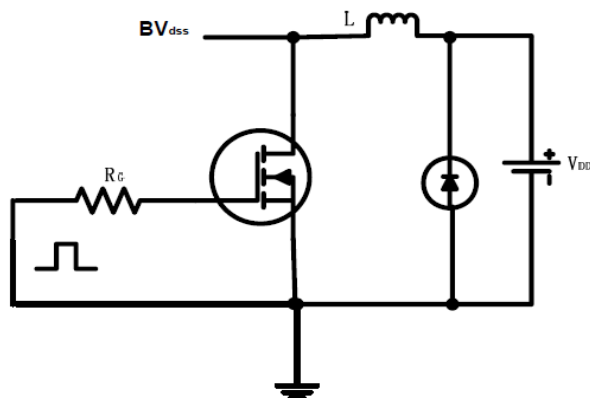
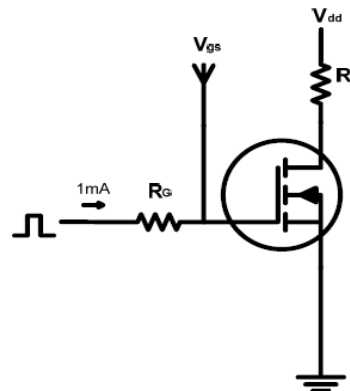
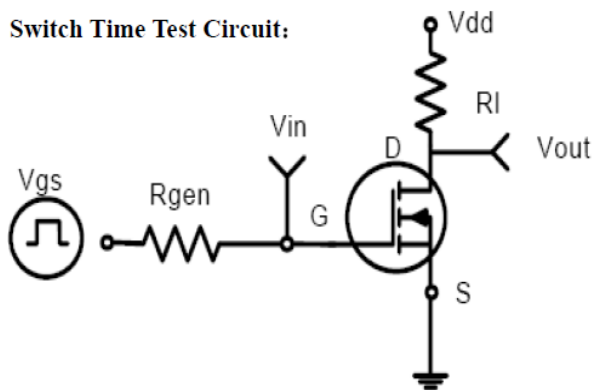
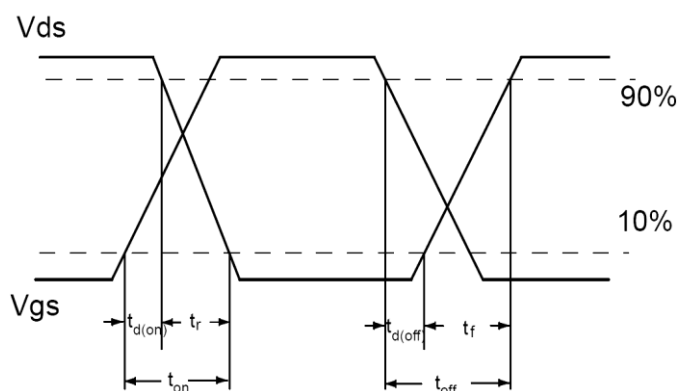
Symbol	Characterizes	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case ③	—	3.85	$^{\circ}C/W$
$R_{\theta JA}$	Junction-to-Ambient ( $t \leq 10s$ ) ④	—	60	$^{\circ}C/W$
	Junction-to-Ambient (PCB mounted, steady-state) ④	—	42	$^{\circ}C/W$

## Electrical Characterizes @ $T_A=25^{\circ}C$ unless otherwise specified

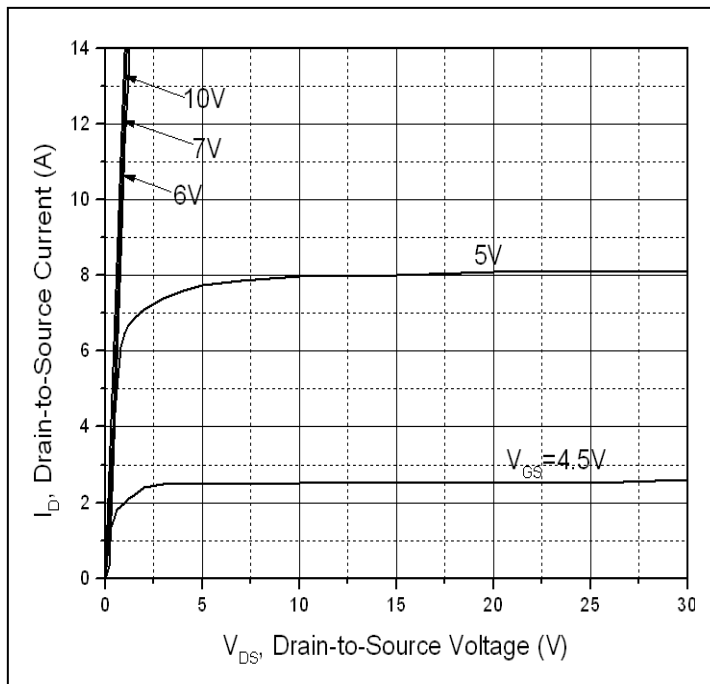
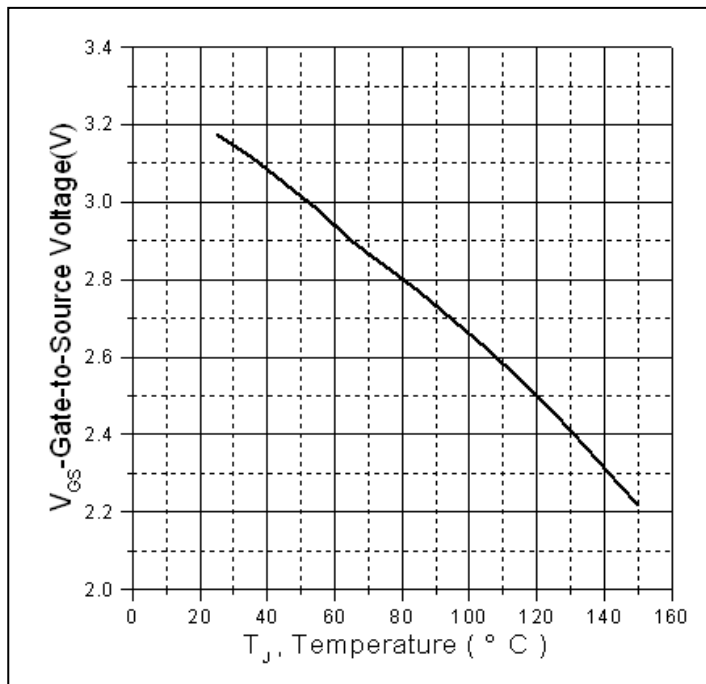
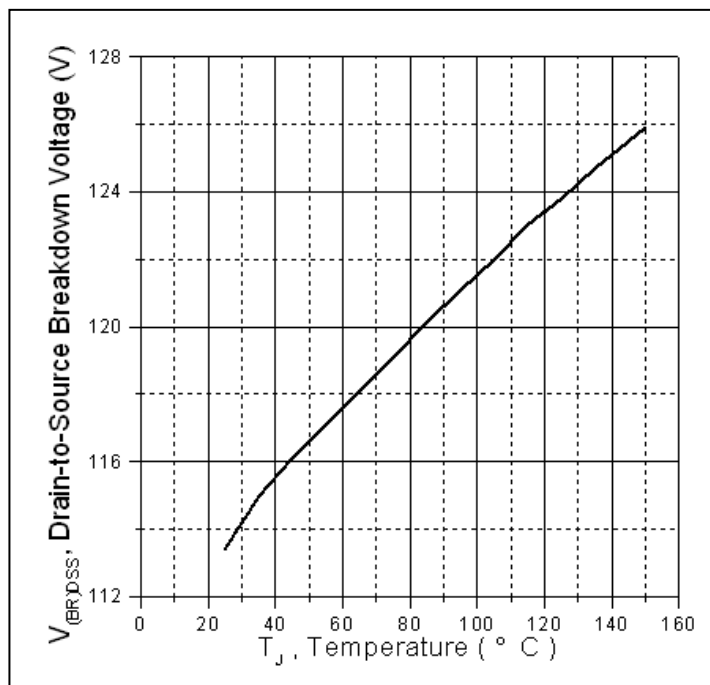
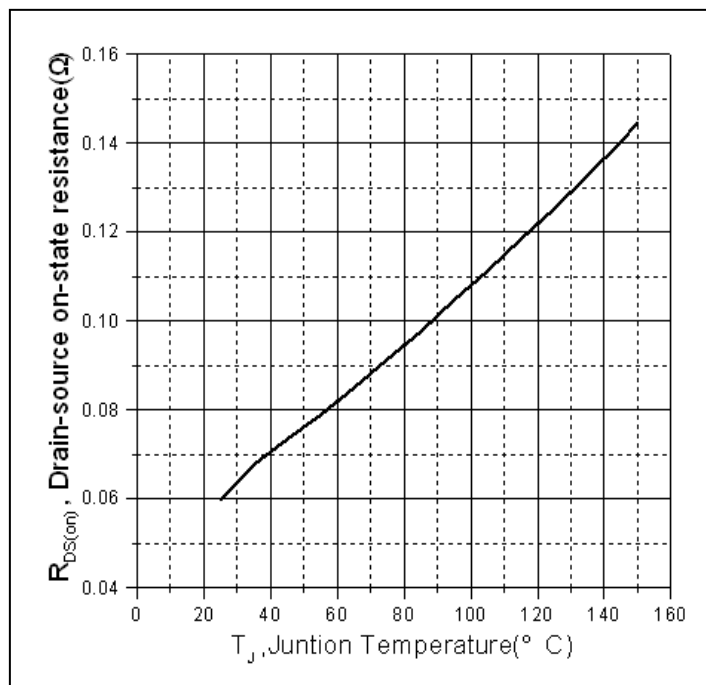
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	60	90	m $\Omega$	$V_{DS}=10V, I_D = 2A$ $T_J = 125^{\circ}C$
		—	125	—		
$V_{GS(th)}$	Gate threshold voltage	2	—	4	V	$V_{DS} = V_{GS}, I_D = 250\mu A$ $T_J = 125^{\circ}C$
		—	2.46	—		
$I_{DSS}$	Drain-to-Source leakage current	—	—	1	$\mu A$	$V_{DS} = 30V, V_{GS} = 0V$ $T_J = 125^{\circ}C$
		—	—	50		
$I_{GSS}$	Gate-to-Source forward leakage	—	—	100	A	$V_{GS} = 20V$ $V_{DS} = -20V$
	Gate-to-Source reverse leakage	—	—	-100		
$Q_g$	Total gate charge	—	20	—	nC	$I_D = 9.2A$ $V_{DD} = 80V$ $V_{GS} = 10V$
$Q_{gs}$	Gate-to-Source charge	—	4.3	—		
$Q_{gd}$	Gate-to-Drain("Miller") charge	—	7.6	—		
$t_{d(on)}$	Turn-on delay time	—	11	—	ns	$V_{GS} = 10V, V_{DD} = 50V,$ $R_L = 5.4\Omega, R_{GEN} = 18\Omega$ $I_D = 9.2A$
$t_r$	Rise time	—	31	—		
$t_{d(off)}$	Turn-Off delay time	—	39	—		
$t_f$	Fall time	—	28	—		
$C_{iss}$	Input capacitance	—	739	—	pF	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1MHz$
$C_{oss}$	Output capacitance	—	58	—		
$C_{riss}$	Reverse transfer capacitance	—	40	—		

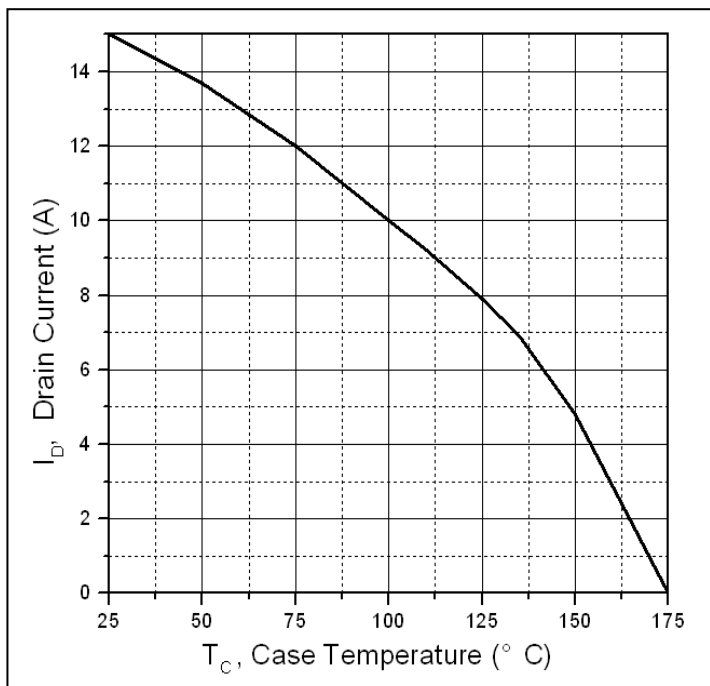
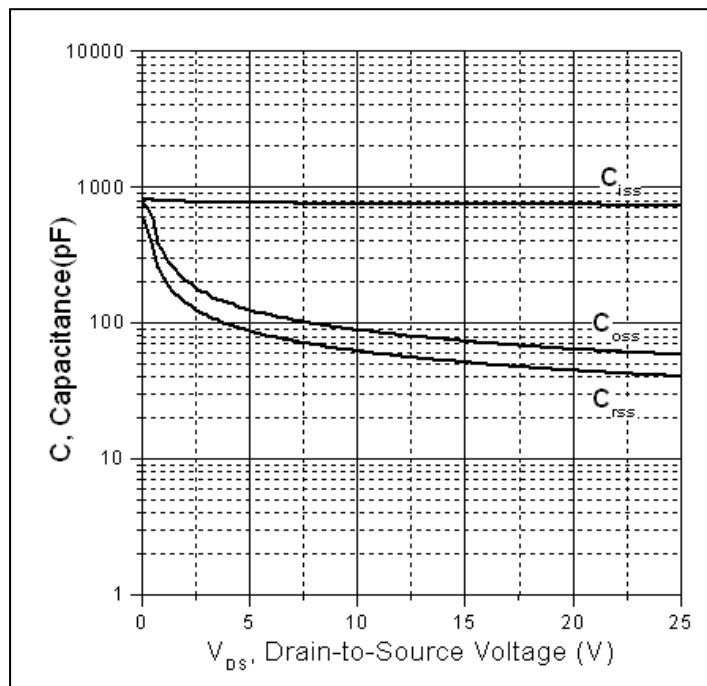
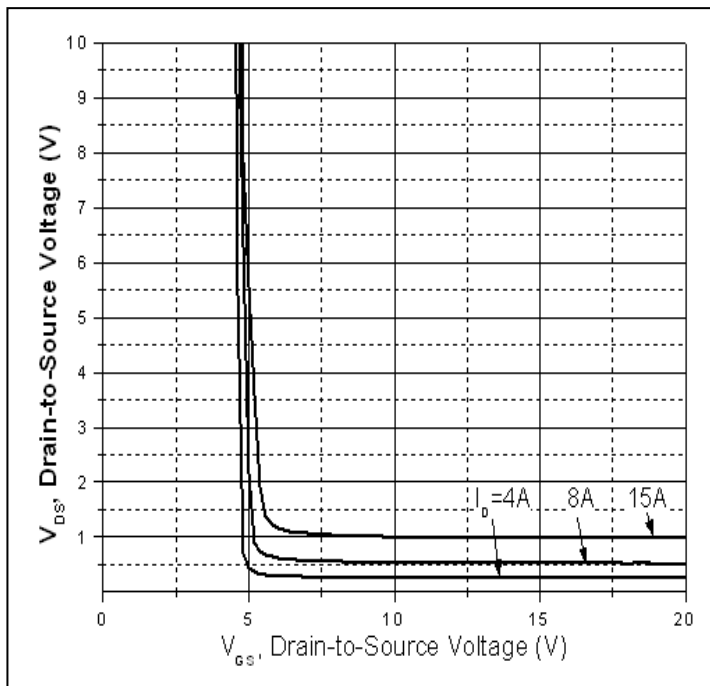
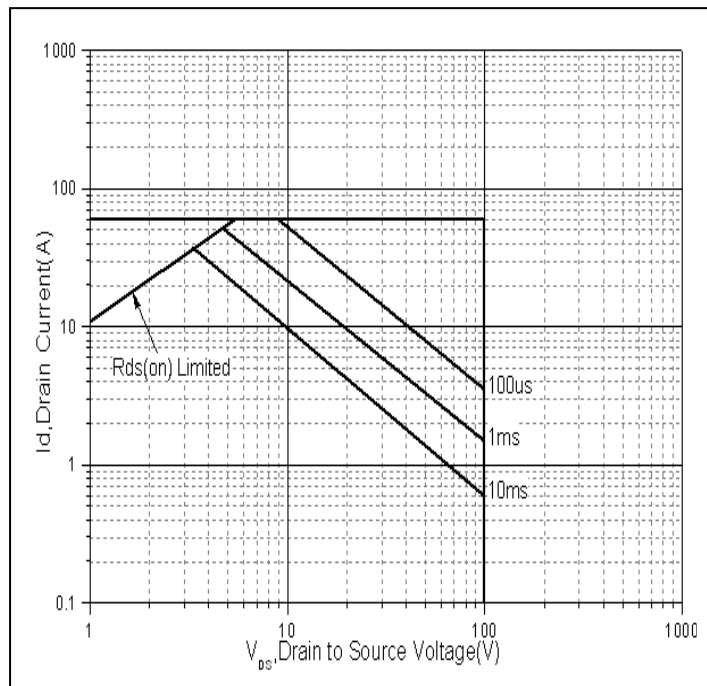
## Source-Drain Ratings and Characteristics

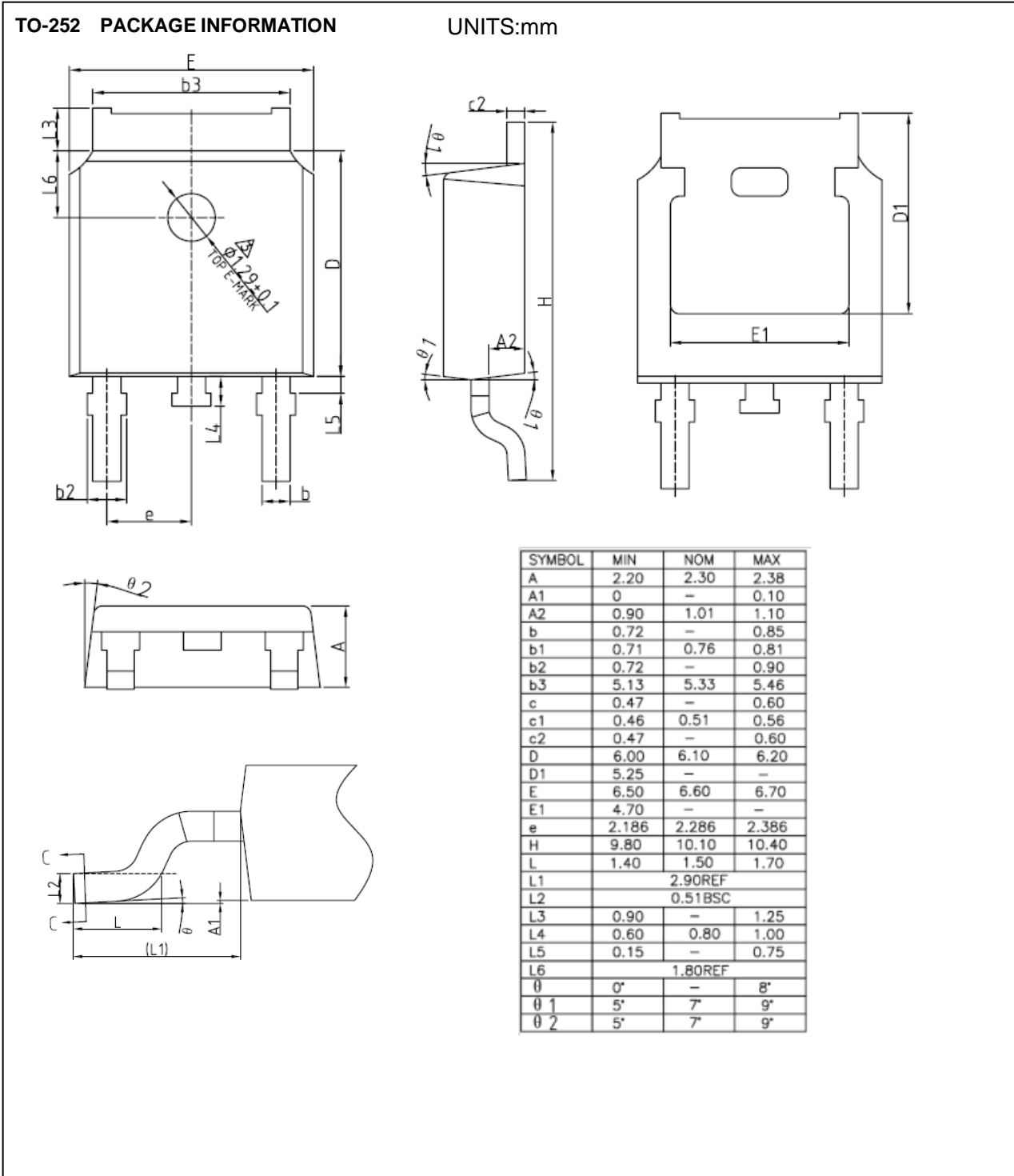
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	15 ①	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode)	—	—	60	A	
$V_{SD}$	Diode Forward Voltage	—	0.8	1.5	V	$I_S = 3A, V_{GS} = 0V, T_J = 25^{\circ}C$
$t_{rr}$	Reverse Recovery Time	—	35	—	ns	$T_J = 25^{\circ}C, I_F = 9.2A,$ $di/dt = 100A/\mu s$
$Q_{rr}$	Reverse Recovery Charge	—	67	—	nC	

**Test circuits and Waveforms**
**EAS test circuits:**

**Gate charge test circuit:**

**Switch Time Test Circuit:**

**Switch Waveforms:**

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$

**Typical electrical and thermal characteristics**

**Figure 1: Typical Output Characteristics**

**Figure 2. Gate to source cut-off voltage**

**Figure 3. Drain-to-Source Breakdown Voltage Vs. Case Temperature**

**Figure 4: Normalized On-Resistance Vs. Case Temperature**

**Typical electrical and thermal characteristics**

**Figure 5. Maximum Drain Current Vs. Case Temperature**

**Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage**

**Figure 7. Drain-to-Source Voltage Vs. Gate-to-Source Voltage**

**Figure 8. Maximum Safe Operating Area**

**Mechanical Data:**


**Ordering and Marking Information**
**Device Marking: SSF1090D**

**Package (Available)**  
**TO-252 (D-PAK)**  
**Operating Temperature Range**  
**C : -55 to 175 °C**

**Devices per Unit**

Package Type	Units/Tape	Tapes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
TO-252	2500	1	2500	7	17500

**Reliability Test Program**

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	T <sub>j</sub> =125°C to 175°C @ 80% of Max V <sub>DSS</sub> /V <sub>CES</sub> /VR	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	T <sub>j</sub> =150°C or 175°C @ 100% of Max V <sub>GSS</sub>	168 hours 500 hours 1000 hours	3 lots x 77 devices

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**Customer Service****Worldwide Sales and Service:**

Sales@silikron.com

**Technical Support:**

Technical@silikron.com

**Suzhou Silikron Semiconductor Corp.**

11A, 428 Xinglong Street, Suzhou Industrial Park, P.R.China

**TEL:** (86-512) 62560688

**FAX:** (86-512) 65160705

**E-mail:** Sales@silikron.com